



Support & training

CD74AC151 SCHS333A – MARCH 2003 – REVISED JULY 2024

CD74AC151 8-Line to 1-Line Data Selector/Multiplexer

1 Features

Texas

INSTRUMENTS

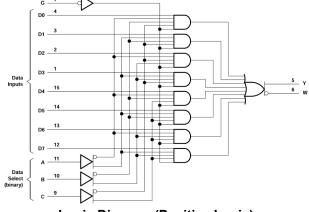
- AC types feature 1.5V to 5.5V operation and balanced noise immunity at 30% of the supply voltage
- 8-line to 1-line multiplexers can perform as:
 - Boolean function generators
 - Parallel-to-serial converters
 - Data source selectors
- Speed of bipolar F, AS, and S, with significantly reduced power consumption balanced propagation delays
- ±24mA output drive current
 - Fanout to 15 F devices
- SCR-latchup-resistant CMOS process and circuit design
- Exceeds 2k V ESD protection per MIL-STD-883, method 3015

2 Description

This data selector/multiplexer provides full binary decoding to select one of eight data sources. The strobe (\overline{G}) input must be at a low logic level to enable the inputs. A high level at the strobe terminal forces the W output high and the Y output low.

PART NUMBER	MBER PACKAGE ⁽¹⁾ PACKAGE ⁽²⁾		BODY SIZE ⁽³⁾
CD74AC151	D (SOIC, 16)	9.90mm × 6mm	9.90mm × 3.90mm
CD/4AC151	N (PDIP, 16)	19.3mm × 9.4mm	19.3mm × 6.35mm

- (1) For more information, see Mechanical, Packaging, and Orderable Information.
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.
- (3) The body size (length × width) is a nominal value and does not include pins.



Logic Diagram (Positive Logic)



Table of Contents

1 Features 2 Description	
3 Pin Configuration and Functions	
4 Specifications	4
4.1 Absolute Maximum Ratings	
4.2 ESD Ratings	4
4.3 Recommended Operating Conditions	4
4.4 Thermal Information	5
4.5 Electrical Characteristics	5
4.6 Switching Characteristics, V _{CC} = 1.5V	5
4.7 Switching Characteristics, V _{CC} = 3.3V ± 0.3V	<mark>6</mark>
4.8 Switching Characteristics, V _{CC} = 5V ± 0.5V	6
4.9 Operating Characteristics	6
5 Parameter Measurement Information	
6 Detailed Description	9

6.1 Functional Block Diagram	9
6.2 Device Functional Modes	
7 Application and Implementation	10
7.1 Power Supply Recommendations	
7.2 Layout	10
8 Device and Documentation Support	11
8.1 Documentation Support (Analog)	11
8.2 Receiving Notification of Documentation Updates.	
8.3 Support Resources	
8.4 Trademarks	11
8.5 Electrostatic Discharge Caution	. 11
8.6 Glossary	
9 Revision History	
10 Mechanical, Packaging, and Orderable	
Information	12



3 Pin Configuration and Functions

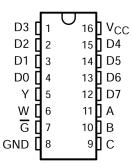


Figure 3-1. D or N Packages; 16-Pin SOIC or PDIP (Top View)	Figure 3-1.	D or N Packages; 16-Pin SOI	C or PDIP (Top View)
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Pin Functions

P	IN	I/O ⁽¹⁾	DESCRIPTION
NO.	NAME	1/0 (**	DESCRIPTION
1	D3	I	Data input 3
2	D2	I	Data input 2
3	D1	I	Data input 1
4	D0	I	Data input 0
5	Y	0	Data output
6	W	0	Data output, inverted
7	G	I	Output strobe, active low
8	GND	_	Ground
9	С	I	Address select C
10	В	I	Address select B
11	A	I	Address select A
12	D7	I	Data input 7
13	D6	I	Data input 6
14	D5	I	Data input 5
15	D4	I	Data input 4
16	V _{CC}	_	Positive supply

(1) I = input, O = output, P = power, FB = feedback, GND = ground, N/A = not applicable



4 Specifications

4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	6	V
I _{IK} ⁽²⁾	Input clamp current	$(V_{I} < 0 \text{ or } V_{I} > V_{CC})$		±20	mA
I _{OK} ⁽²⁾	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC})$		±50	mA
Ι _Ο	Continuous output current	$(V_{O} = 0 \text{ to } V_{CC})$		±50	mA
	Continuous current through V_{CC} or GND			±100	mA
T _{stg}	Storage temperature range		-65	150	°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

4.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾	±2000	V

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.

4.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			T _A = 25°C		-55°C to	125°C	-40°C to 85°C		UNIT
		-	MIN	MAX	MIN	MAX	MIN	MAX	UNII
V _{CC}	Supply voltage		1.5	5.5	1.5	5.5	1.5	5.5	V
		V _{CC} = 1.5 V	1.2		1.2		1.2		
VIH	High-level input voltage	V _{CC} = 3 V	2.1		2.1		2.1		V
		V _{CC} = 5.5 V	3.85		3.85		3.85		
		V _{CC} = 1.5 V		0.3		0.3		0.3	
V _{IL}	Low-level input voltage	V _{CC} = 3 V		0.9		0.9		0.9	V
		V _{CC} = 5.5 V		1.65		1.65		1.65	
VI	Input voltage		0	V _{CC}	0	V _{CC}	0	V _{CC}	V
Vo	Output voltage		0	V _{CC}	0	V_{CC}	0	V _{CC}	V
I _{OH}	High-level output current	V _{CC} = 4.5 V to 5.5 V		-24		-24		-24	mA
I _{OL}	Low-level output current	V _{CC} = 4.5 V to 5.5 V		24		24		24	mA
		V _{CC} = 1.5 V to 3 V		50		50		50	
Δt/Δv	Input transition rise or fall rate	V _{CC} = 3.6 V to 5.5 V		20		20		20	ns/V

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



4.4 Thermal Information

		D (SOIC)	N (PDIP)	
THERMAL METRIC	•	16 PINS	16 PINS	UNIT
R _{0JA}	Junction-to-ambient thermal resistance ⁽¹⁾	119.9	67	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

4.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS			TA = 2	TA = 25°C		125°C	-40°C to 85°C		
V _{OH}	TEST CO	MIN		MAX	MIN	MAX	MIN	MAX	UNIT	
			1.5 V	1.4		1.4		1.4		
V _{он}		I _{OH} = -50 μA	3 V	2.9		2.9		2.9		
			4.5 V	4.4		4.4		4.4		V
	$V_{I} = V_{IH} \text{ or } V_{IL}$	I _{OH} = -4 mA	3 V	2.58		2.4		2.48		
		I _{OH} = -24 mA	4.5 V	3.94		3.7		3.8		
		I _{OH} = -50 mA ⁽¹⁾	5.5 V			3.85				
		I _{OH} = -75 mA ⁽¹⁾	5.5 V					3.85		
	VI = VIH or VIL		1.5 V		0.1		0.1		0.1	
		I _{OL} = 50 μA	3 V		0.1		0.1		0.1	
			4.5 V		0.1		0.1		0.1	
V _{OL}		I _{OL} = 12 mA	3 V		0.36		0.5		0.44	V
		I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	
		I _{OL} = 50 mA ⁽¹⁾	5.5 V				1.65		-	
		I _{OL} = 75 mA ⁽¹⁾	5.5 V						1.65	
l _l	$V_{I} = V_{CC}$ or GND		5.5 V		±0.1		±1		±1	μA
I _{CC}	$V_{I} = V_{CC}$ or GND,	I _O = 0	5.5 V		8		160		80	μA
C _i					10	· · · ·	10		10	pF

(1) Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.

4.6 Switching Characteristics, V_{CC} = 1.5V

over recommended operating free-air temperature range, V_{CC} = 1.5V, C_L = 50pF (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER		FROM (INPUT) TO (OUTPUT)		-40°C to 85°C	UNIT
FARAMETER		10 (001901)	MIN MAX	MIN MAX	UNIT
t _{PLH}	D	Y	169	152	ns
t _{PHL}			169	152	115
t _{PLH}	D	W	186	169	ns
t _{PHL}	U	vv	186	169	115
t _{PLH}	A, B, or C	Y	228	207	ns
t _{PHL}	Α, Β, ΟΙ Ο	I	228	207	115
t _{PLH}	A, B, or C	W	245	223	ns
t _{PHL}	A, B, O C	VV	245	223	115
t _{PLH}	- G	Y	153	139	ns
t _{PHL}			153	139	115

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over recommended operating free-air temperature range, V_{CC} = 1.5V, C_L = 50pF (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	-55°C to 125°C	-40°C to 85°C	UNIT	
			MIN MAX	MIN MAX		
t _{PLH}	Ē	W	169	153		
t _{PHL}	G	VV	169	153	ns	

4.7 Switching Characteristics, V_{CC} = 3.3V ± 0.3V

over recommended operating free-air temperature range, $V_{CC} = 3.3V \pm 0.3V$, $C_L = 50pF$ (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	-55°C to 1	25°C	-40°C to	85°C	UNIT	
PARAMETER		10 (001901)	MIN	MAX	MIN	MAX	UNIT	
t _{PLH}	D	Y -	4.7	18.9	4.9	17.1	20	
t _{PHL}		T	4.7	18.9	4.9	17.1	ns	
t _{PLH}	D	W	5.2	20.9	5.4	19	20	
t _{PHL}		VV –	5.2	20.9	5.4	19	ns	
t _{PLH}		Y	6.4	25.5	6.6	23.2	ns	
t _{PHL}	A, B, or C		6.4	25.5	6.6	23.2		
t _{PLH}	A D or C	14/	6.9	27.4	7.1	24.9	ns	
t _{PHL}	A, B, or C	W	6.9	27.4	7.1	24.9		
t _{PLH}	G	V	4.3	17.1	4.4	15.5	ns	
t _{PHL}	G	Y	4.3	17.1	4.4	15.5		
t _{PLH}	G	14/	4.7	18.9	4.9	17.2		
t _{PHL}	G	W	4.7	18.9	4.9	17.2	ns	

4.8 Switching Characteristics, V_{CC} = 5V ± 0.5V

over recommended operating free-air temperature range, $V_{CC} = 5V \pm 0.5V$, $C_L = 50pF$ (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

DADAMETED			-55°C to 1	25°C	-40°C to	85°C	UNIT
PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	MIN	MAX	
t _{PLH}	D	Y	3.4	13.5	3.5	12.3	ns
t _{PHL}	U	T	3.4	13.5	3.5	12.3	115
t _{PLH}	D	W	3.7	14.9	3.8	13.5	nc
t _{PHL}	U	vv	3.7	14.9	3.8	13.5	ns
t _{PLH}	A D or C	Y	4.6	18.2	4.7	16.5	ns
t _{PHL}	A, B, or C	ř	4.6	18.2	4.7	16.5	
t _{PLH}	A, B, or C	W	4.9	19.6	5.1	17.8	ns
t _{PHL}	A, B, OI C	vv	4.9	19.6	5.1	17.8	
t _{PLH}	G	Y	3.1	12.2	3.1	11.1	ns
t _{PHL}	G	Y Y	3.1	12.2	3.1	11.1	
t _{PLH}	G	W	3.4	13.5	3.5	12.3	ns
t _{PHL}	G	VV V	3.4	13.5	3.5	12.3	

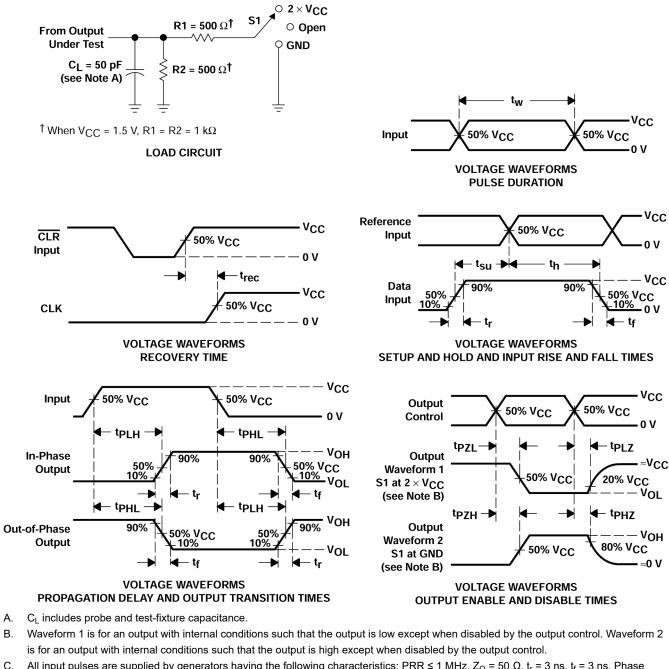
4.9 Operating Characteristics

V_{CC} = 5V, T_A = 25°C

	PARAMETER	TYP	UNIT
C _{pd}	Power dissipation capacitance	120	pF



5 Parameter Measurement Information



- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_0 = 50 \Omega$, $t_r = 3$ ns, $t_f = 3$ ns. Phase relationships between waveforms are arbitrary.
- D. For clock inputs, f_{max} is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. t_{PLH} and t_{PHL} are the same as t_{pd} .
- G. t_{PZL} and t_{PZH} are the same as t_{en} .
- H. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- I. All parameters and waveforms are not applicable to all devices.

Figure 5-1. Load Circuit and Voltage Waveforms



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	$2 \times V_{CC}$
t _{PHZ} /t _{PZH}	GND



6 Detailed Description

6.1 Functional Block Diagram

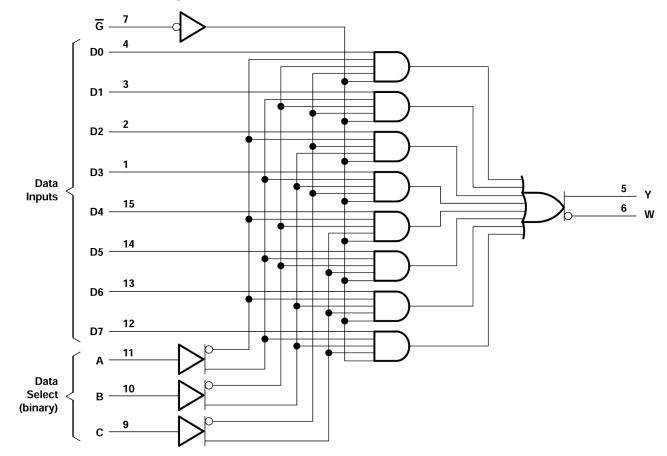


Figure 6-1. Logic Diagram (Positive Logic)

6.2 Device Functional Modes

			Table 6-1. Function	Table			
		INPUT	6	OUTPUTS			
	SELECT			Y	w		
С	В	Α	STROBE G	T	vv		
Х	Х	Х	Н	L	Н		
L	L	L	L	D0	D0		
L	L	Н	L	D1	<u>D1</u>		
L	Н	L	L	D2	D2		
L	Н	Н	L	D3	<u>D3</u>		
Н	L	L	L	D4	<u>D4</u>		
Н	L	Н	L	D5	<u>D5</u>		
Н	Н	L	L	D6	<u>D6</u>		
Н	Н	Н	L	D7	D7		



7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1-µF capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1-µF and 1-µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

7.2 Layout

7.2.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.



8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 Documentation Support (Analog)

8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY								
CD74AC151	Click here	Click here	Click here	Click here	Click here								

Table 8-1. Related Links

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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8.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

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8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision * (March 2003) to Revision A (July 2024)	Page
•	Added Package Information table, Pin Functions table, ESD Ratings table, Thermal Information table, I	Device
	Functional Modes, Application and Implementation section, Device and Documentation Support section	, and
	Mechanical, Packaging, and Orderable Information section	1
•	Updated RθJA values: D = 73 to 119.9, all values in °C/W	<mark>5</mark>



10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74AC151E	ACTIVE	PDIP	Ν	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC151E	Samples
CD74AC151M96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC151M	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

21-May-2024



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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC151M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74AC151M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1



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PACKAGE MATERIALS INFORMATION

11-Dec-2024



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC151M96	SOIC	D	16	2500	353.0	353.0	32.0
CD74AC151M96	SOIC	D	16	2500	353.0	353.0	32.0

TEXAS INSTRUMENTS

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11-Dec-2024

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
CD74AC151E	N	PDIP	16	25	506	13.97	11230	4.32
CD74AC151E	N	PDIP	16	25	506	13.97	11230	4.32

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



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